Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10664635	NAKAMURA, MITSUHIRO	
Examiner	Art Unit	
Hoang, Hieu T	2152	

SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES				
Search Notes	Date	Examiner		
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INTERFERENCE SEARCH					
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